Search Notes

Application No.	Applicant(s)	
10/643,193	BHAVNAGARWALA ET AL.	
Examiner	**Art Unit**	
Jeffrey R. West	2857	

SEARCHED			
Class	Subclass	Date	Examiner
702	57,58,64 65,66	1/23/2005	JRW
702	85,182	1/23/2005	JRW
702	117	1/13/2005	JRW
702	189	1/23/2005	JRW

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Search Online Search IEEE Xplore	1/13/2005	JRW
(threshold or thresholds) with (voltage or voltages) with (mismatch or mismatches or mismatching or mismatched)	1/13/2005	JRW
(((vary or varies or varied or varying) with (gate) near (voltage or voltages)) with (transistor or transistors or fet or fet	1/13/2005	JRW
s or mosfet or mosfets or cmosfet or cmosfets)) same (subthreshold or subthresholds or sub-threshold or sub-thresholds or (b	1/13/2005	JRW
elow adj2 (threshold or thresholds)))	1/13/2005	JRW
threshold with voltage with (mismatch or mismatches or mismatching or mismatched or mis-match or mis-matches or mis-matching	1/19/2005	JRW
or mis-matched or match or matches or matching or matched) with (transistor or transistors) with (pair or pairs or paired)	1/19/2005	**JRW**